

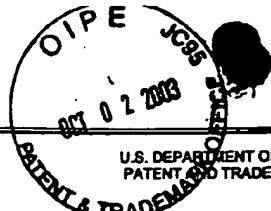


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Technology Center 2600 SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 202594US2RD	SERIAL NO. 09/772,894		
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT		Junichi AKIYAMA, et al.			
		FILING DATE		January 31, 2001			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO	
	AO	2-037501	02/07/90	JAPAN (with English Abstract)	—	X	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	H. KATAYAMA, et al., J. Magn. Soc. Jpn., Vol. 32, No. 8, pps. 1901-1906, "LASER-ASSISTED MAGNETIC RECORDING TECHNOLOGIES," 1999					
	AX	H. KATAYAMA, et al., Proceedings of Magneto-Optical Recording International Symposium '99, J. Magn. Soc. Jpn., Vol. 23, No. S1, pps. 233-236, "NEW MAGNETIC RECORDING METHOD USING LASER ASSISTED READ/WRITE TECHNOLOGIES," 1999					
	AY	H. SAGA, et al., Proceedings of Magneto-Optical Recording International Symposium '99, J. Magn. Soc. Jpn., Vol. 23, No. S1, pps. 225-228, "A NEW PERPENDICULAR MAGNETIC RECORDING METHOD WITH A MAGNETIC-OPTICAL COMMON PREFORMAT," 1999					
	AZ						
Examiner <i>Pat</i>				Date Considered <i>9/20/02</i>			
<p><i>Patent Office</i></p> <p>"Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>							



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LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Junichi AKIYAMA, et al.					
		FILING DATE January 31, 2001		GROUP 2653			
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	AP	02-189751	07/25/90	Japan (w/English Abstract)	<input checked="" type="checkbox"/>	<input type="checkbox"/>	x
	AQ	06-203303	07/22/94	Japan (w/English Abstract)	<input checked="" type="checkbox"/>	<input type="checkbox"/>	x
	AR	06-243527	09/02/94	Japan (w/English Abstract)	<input checked="" type="checkbox"/>	<input type="checkbox"/>	x
	AS	11-265520	09/28/99	Japan (w/English Abstract)	<input checked="" type="checkbox"/>	<input type="checkbox"/>	x
	AT	11-096608	04/09/99	Japan (w/English Abstract)	<input checked="" type="checkbox"/>	<input type="checkbox"/>	x
	AU				<input type="checkbox"/>	<input type="checkbox"/>	
	AV				<input type="checkbox"/>	<input type="checkbox"/>	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner <i>PS/DS</i>							Date Considered <i>11/13/03</i>

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PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT

ATTY DOCKET NO. 202594US2RD
SERIAL NO. 09/772,894

APPLICANT
Junichi AKIYAMA, et al.

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AW	Gen-ichi HATAKOSHI and Hideo FURUYAMA, "Polarization Dependence Analysis of Optical Loss in Small-Aperture Metal Waveguides for Near-Field Optics," Jpn. J. Appl. Phys. Vol. 40 (2001), pp. 1548-1551 <i>to complete</i> <i>late</i>
AX	
AY	
AZ	<input type="checkbox"/> Additional References sheet(s) attached

Examiner *Bob* Date Considered *5/10/04*

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